56 ∏ D4

55 D3

54 D2

52 D1 51 D0

50 D27

48 YOM

47 Y0P

46 ¶ Y1M

45 Y1P

41 Y2P

38 T Y3M

37 N Y3P

49 LVDSGND

44 LVDSV<sub>CC</sub>

43 LVDSGND 42 1 Y2M

40 CLKOUTM

39 CLKOUTP

36 LVDSGND

35 PLLGND

34 PLLV<sub>CC</sub>

33 | PLLGND

32 SHTDN

**GND** 

31 T CLKIN

30 D26

29

53 GND

**DGG PACKAGE** (TOP VIEW)

Vcc L

D7

D8 ∏

D9 7

Vcc [ 9

D13 [

D15 Π

D17 ∏

D19

GND

D20

D21

D22

D23

 $V_{CC}$ 

D25

D24  $\Pi$ 

D11 **∏** 10

D12 **1** 11

GND [] 13

D14 Π 14

D16 **∏** 16 CLKSEL 17

D18 **∏** 19

D10 П 8

D5 Π 2

D6 [] 3

 $\Pi_4$ GND [] 5

6

12

15

18

20 П

21

22

23

24

25

26

27

28

- 4:28 Data Channel Compression at up to 238 MBytes/s Throughput
- Suited for SVGA, XGA, or SXGA Display **Data Transmission From Controller to Display With Very Low EMI**
- 28 Data Channels and Clock-In Low-Voltage
- 4 Data Channels and Clock-Out **Low-Voltage Differential**
- Operates From a Single 3.3-V Supply With 250 mW (Typ)
- **ESD Protection Exceeds 6 kV**
- **5-V Tolerant Data Inputs**
- Selectable Rising or Falling Edge-Triggered Inputs
- Packaged in Thin Shrink Small-Outline Package With 20-Mil Terminal Pitch
- Consumes Less Than 1 mW When Disabled
- Wide Phase-Lock Input Frequency Range . . . 31 MHz to 68 MHz
- No External Components Required for PLL
- **Outputs Meet or Exceed the Requirements** of ANSI EIA/TIA-644 Standard
- Improved Replacement for the DS90C581

#### description

The SN75LVDS83 FlatLink transmitter contains four 7-bit parallel-load serial-out shift registers, a

7× clock synthesizer, and five low-voltage

differential-signaling (LVDS) line drivers in a single integrated circuit. These functions allow 28 bits of single-ended low-voltage TTL (LVTTL) data to be synchronously transmitted over five balanced-pair conductors for receipt by a compatible receiver, such as the SN75LVDS82. The SN75LVDS83 can also be used in 21-bit links with the SN75LVDS86 receiver.

When transmitting, data bits D0 through D27 are each loaded into registers upon the edge of the input clock signal (CLKIN). The rising or falling edge of the clock can be selected by way of the clock select (CLKSEL) terminal. The frequency of CLKIN is multiplied seven times (7×) and then used to unload the data registers in 7-bit slices and serially. The four serial streams and a phase-locked clock (CLKOUT) are then output to LVDS output drivers. The frequency of CLKOUT is the same as the input clock, CLKIN.

The SN75LVDS83 requires no external components and little or no control. The data bus appears the same at the input to the transmitter and output of the receiver with the data transmission transparent to the user. The only user intervention is the possible use of the shutdown/clear (SHTDN) active-low input to inhibit the clock and shut off the LVDS output drivers for lower power consumption. A low-level signal on SHTDN clears all internal registers to a low level.

The SN75LVDS83 is characterized for operation over free-air temperature ranges of 0°C to 70°C.



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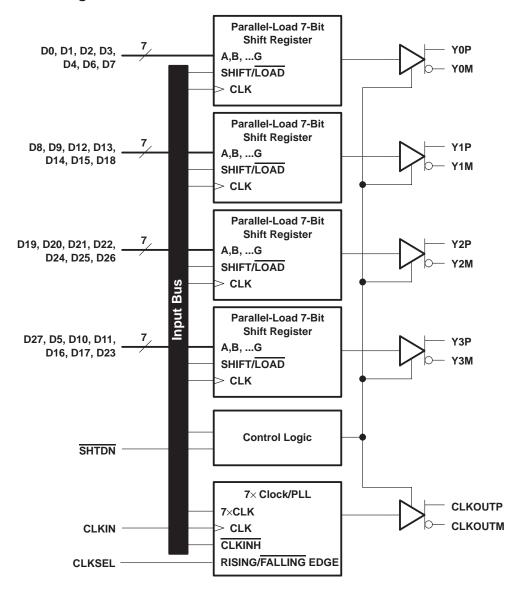
ISTRUMENTS

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## functional block diagram



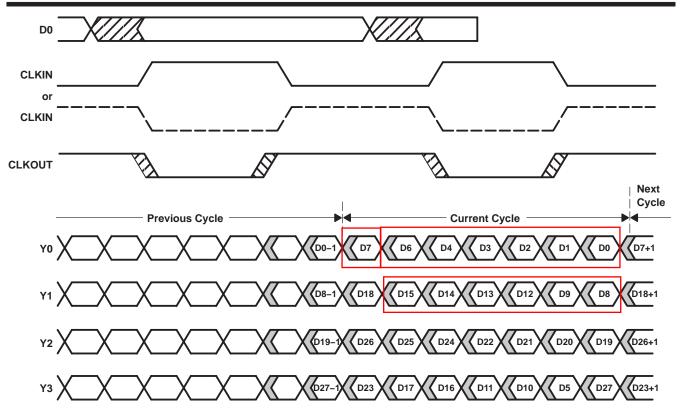
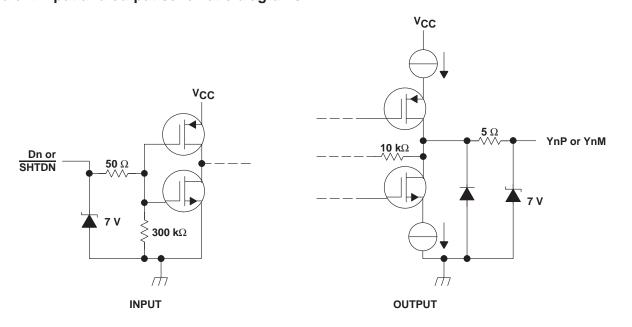


Figure 1. SN75LVDS83 Load and Shift Timing Sequences

## equivalent input and output schematic diagrams



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## absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub> (see Note 1)	–0.5 V to 4 V
Output voltage range, VO (all terminals)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input voltage range, V <sub>I</sub> (all terminals)	–0.5 V to 5.5 V
Continuous total power dissipation	See Dissipation Rating Table
Storage temperature range, T <sub>stq</sub>	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

NOTE 1: All voltage values are with respect to the GND terminals.

#### **DISSIPATION RATING TABLE**

PACKAGE	$T_{\mbox{A}} \le 25^{\circ}\mbox{C}$ POWER RATING	DERATING FACTOR‡ ABOVE T <sub>A</sub> = 25°C	T <sub>A</sub> = 70°C POWER RATING		
DGG	1377 mW	11.0 mW/°C	822 mW		

<sup>&</sup>lt;sup>‡</sup> This is the inverse of the junction-to-ambient thermal resistance when board mounted and with no air flow.

## recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V <sub>CC</sub>	3	3.3	3.6	V
High-level input voltage, VIH	2			V
Low-level input voltage, V <sub>IL</sub>			8.0	V
Differential load impedance, Z <sub>L</sub>	90		132	Ω
Operating free-air temperature, T <sub>A</sub>	0		70	°C

## timing requirements

		MIN	NOM MAX	UNIT
t <sub>C</sub>	Cycle time, input clock	14.7	32.3	ns
t <sub>W</sub>	Pulse duration, high-level input clock	0.4 t <sub>C</sub>	0.6t <sub>C</sub>	ns
t <sub>t</sub>	Transition time, input signal		5	ns
t <sub>su</sub>	Setup time, data, D0 – D27 valid before CLKIN↑ or CLKIN↓ (see Figure 2)	3		ns
th	Hold time, data, D0 – D27 valid after CLKIN↑ or CLKIN↓ (see Figure 2)	1.5		ns



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## electrical characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>†</sup>	MAX	UNIT
VIT	Input threshold voltage			1.4		V
V <sub>OD</sub>	Differential steady-state output voltage magnitude		247		454	mV
Δ V <sub>OD</sub>	Change in the steady-state differential output voltage magnitude between opposite binary states	$R_L$ = 100 Ω, See Figure 3			50	mV
V <sub>OC</sub> (SS)	Steady-state common-mode output voltage	0 5	1.125		1.375	V
V <sub>OC(PP)</sub>	Peak-to-peak common-mode output voltage	See Figure 3			150	mV
I <sub>IH</sub>	High-level input current	V <sub>IH</sub> = V <sub>CC</sub>			25	μΑ
IIL	Low-level input current	V <sub>IL</sub> = 0			±10	μΑ
1	Chart singuit sydes a symmet	$V_{O(Yn)} = 0$			±24	mA
los	Short-circuit output current	V <sub>OD</sub> = 0			±12	mA
I <sub>OZ</sub>	High-impedance state output current	$V_O = 0$ to $V_{CC}$			±10	μΑ
		Disabled, All inputs at GND			280	μΑ
I <sub>CC</sub>	Quiescent supply current	Enabled, $R_L = 100 \Omega$ , Gray-scale pattern (see Figure 4), $V_{CC} = 3.3 \text{ V}$ , $t_C = 15.38 \text{ ns}$		72	90	mA
		Enabled, $R_L = 100 \Omega$ , Worst-case pattern (see Figure 5), $t_C = 15.38 \text{ ns}$		85	110	mA
Cl	Input capacitance			3		pF

 $<sup>\</sup>dagger$  All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.

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## switching characteristics over recommended operating conditions (unless otherwise noted)

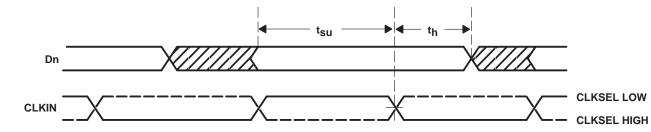
	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>†</sup>	MAX	UNIT
t <sub>d0</sub>	Delay time, CLKOUT↑ to serial bit position 0		-0.2	0	0.2	ns
<sup>t</sup> d1	Delay time, CLKOUT↑ to serial bit position 1		$\frac{1}{7}t_{C} - 0.2$		$\frac{1}{7}$ t <sub>C</sub> + 0.2	ns
t <sub>d2</sub>	Delay time, CLKOUT↑ to serial bit position 2		$\frac{2}{7}t_{C} - 0.2$		$\frac{2}{7}t_{C} + 0.2$	ns
t <sub>d3</sub>	Delay time, CLKOUT↑ to serial bit position 3	$t_{\rm C} = 15.38 \text{ ns } (\pm 0.2\%),$	$\frac{3}{7}t_{C} - 0.2$		$\frac{3}{7}t_{\rm C} + 0.2$	ns
t <sub>d4</sub>	Delay time, CLKOUT↑ to serial bit position 4	Input clock jitter  < 50 ps <sup>‡</sup> , See Figure 6	$\frac{4}{7}t_{C}-0.2$		$\frac{4}{7}t_{C} + 0.2$	ns
t <sub>d5</sub>	Delay time, CLKOUT↑ to serial bit position 5		$\frac{5}{7}t_{C}-0.2$		$\frac{5}{7}$ t <sub>C</sub> + 0.2	ns
<sup>t</sup> d6	Delay time, CLKOUT↑ to serial bit position 6		$\frac{6}{7}t_{C}-0.2$		$\frac{6}{7}$ t <sub>C</sub> + 0.2	ns
tsk(o)	Output skew, $t_n - \frac{n}{7}t_C$		-0.2		0.2	ns
t <sub>d7</sub>	Delay time, CLKIN↓ to CLKOUT↑	$t_C = 18.51 \text{ ns } (\pm 0.2\%),$  Input clock jitter  < 50 ps <sup>‡</sup> , See Figure 6	3.75	5.6	7.75	ns
		$t_{\rm C} = 15.38 \pm 0.75 \ {\rm sin} \ (2\pi 500 {\rm E}3t) + 0.05 \ {\rm ns},$ See Figure 7		±70		ps
∆t <sub>C</sub> (o)	Cycle time, output clock jitter§	$t_{\text{C}} = 15.38 \pm 0.75 \text{ sin } (2\pi 3\text{E6t}) + 0.05 \text{ ns},$ See Figure 7		±187		ps
t <sub>W</sub>	Pulse duration, high-level output clock			$\frac{4}{7}t_{C}$		ns
t <sub>t</sub>	Transition time, differential output (t <sub>r</sub> or t <sub>f</sub> )	See Figure 3	260	700	1500	ps
t <sub>en</sub>	Enable time, SHTDN↑ to phase lock (Yn valid)	See Figure 8		1		ms
t <sub>dis</sub>	Disable time, SHTDN↓ to off state (CLKOUT low)	See Figure 9		250		ns

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

<sup>‡ |</sup>Input clock jitter| is the magnitude of the change in the input clock period.
§ Output clock jitter is the change in the output clock period from one cycle to the next cycle observed over 15 000 cycles.

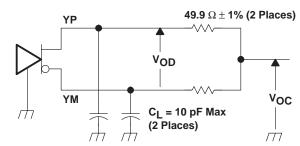
SN75LVDS83

## PARAMETER MEASUREMENT INFORMATION



NOTE A: All input timing is defined at 1.4 V on an input signal with a 10%-to-90% rise or fall time of less than 5 ns.

Figure 2. Setup and Hold Time Waveforms



NOTE A: The lumped instrumentation capacitance for any single-ended voltage measurement is less than or equal to 10 pF. When making measurements at YP or YM, the complementary output is similarly loaded.

## (a) SCHEMATIC

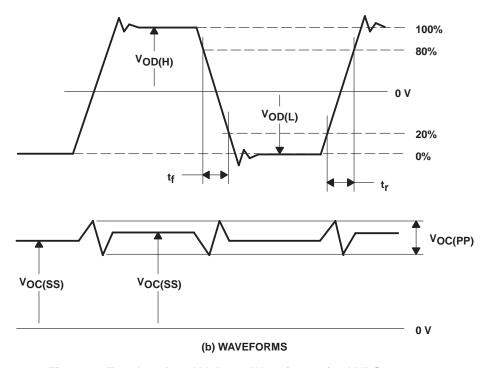
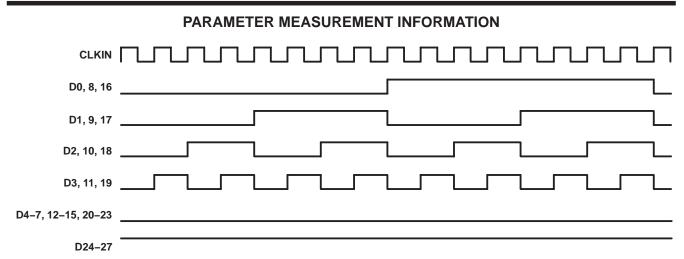


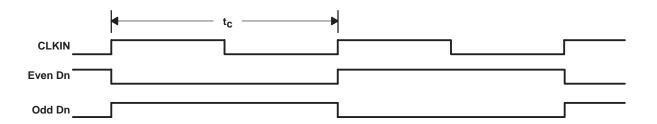
Figure 3. Test Load and Voltage Waveforms for LVDS Outputs





NOTE A: The 16-grayscale test-pattern test device power consumption for a typical display pattern. Pattern with CLKSEL low shown.

Figure 4. 16-Grayscale Test-Pattern Waveforms



NOTE A: The worst-case test pattern produces nearly the maximum switching frequency for all of the LVDS outputs. Pattern with CLKSEL low shown.

Figure 5. Worst-Case Test-Pattern Waveforms



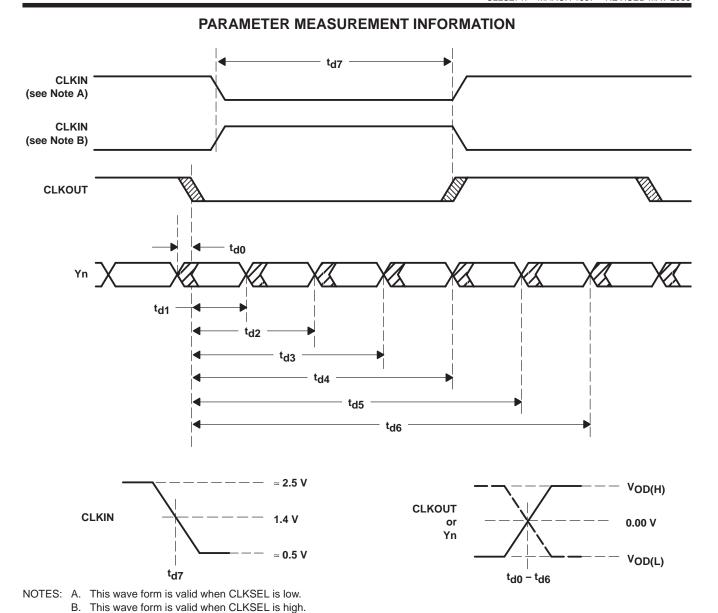
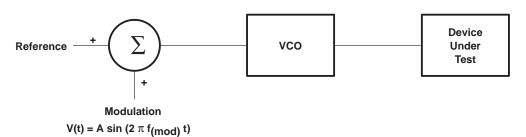


Figure 6. SN75LVDS83 Timing Waveforms

## PARAMETER MEASUREMENT INFORMATION



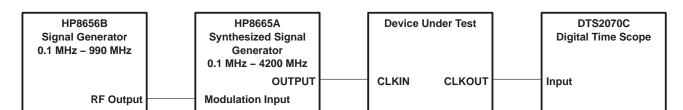


Figure 7. Output Clock Jitter Testing

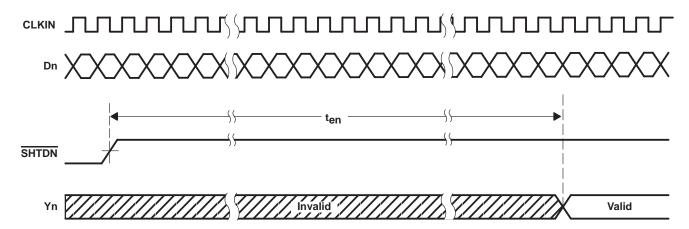


Figure 8. Enable Time Waveforms

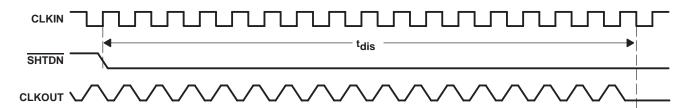


Figure 9. Disable Time Waveforms



## **TYPICAL CHARACTERISTICS**

# AVERAGE SUPPLY CURRENT vs CLOCK FREQUENCY

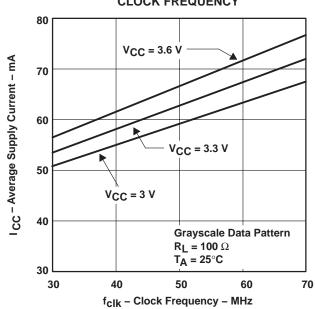


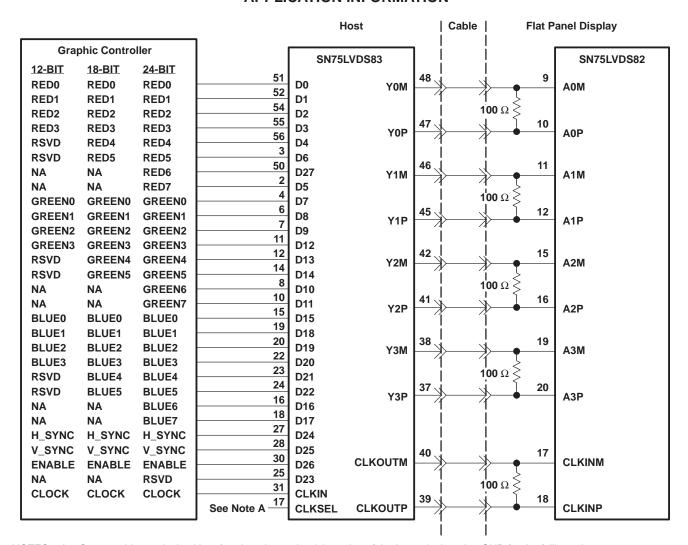
Figure 10

## **ZERO-TO-PEAK OUTPUT JITTER**

٧S **MODULATION FREQUENCY** 200 180 160 Zero-to-Peak Output Jitter - ps 140 120 100 80 60 40 Input jitter = 750 sin (6.28  $f_{(mod)}$  t) ps  $V_{CC} = 3.3 V$ 20 T<sub>A</sub> = 25°C 0 0 0.5 1.5 2 3 f<sub>(mod)</sub> - Modulation Frequency - MHz

Figure 11

#### APPLICATION INFORMATION



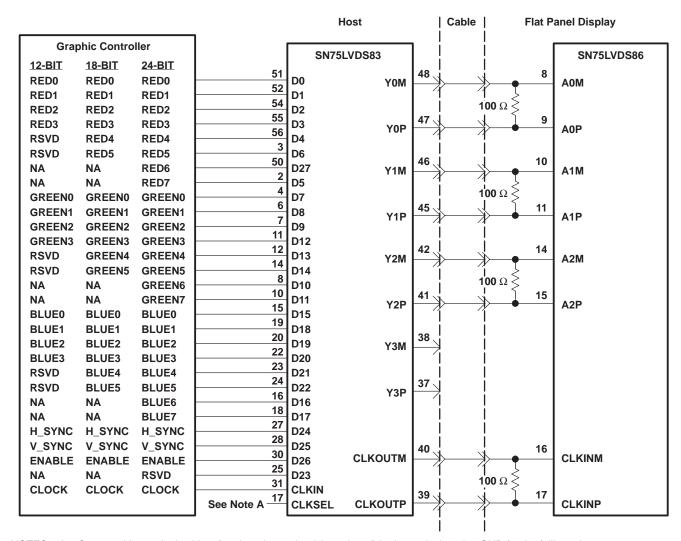
NOTES: A. Connect this terminal to  $V_{\hbox{CC}}$  for triggering to the rising edge of the input clock and to GND for the falling edge.

B. The five  $100-\Omega$  terminating resistors are recommended to be 0603 types.

Figure 12. 24-Bit Color Host To 24-Bit LCD Panel Display Application

SN75LVDS83

#### **APPLICATION INFORMATION**



NOTES: A. Connect this terminal to  $V_{CC}$  for triggering to the rising edge of the input clock and to GND for the falling edge.

B. The four  $100-\Omega$  terminating resistors are recommended to be 0603 types.

Figure 13. 24-Bit Color Host To 18-Bit LCD Panel Display Application

#### PACKAGE OPTION ADDENDUM

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#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN75LVDS83DGG	ACTIVE	TSSOP	DGG	56	35	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN75LVDS83DGGG4	ACTIVE	TSSOP	DGG	56	35	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN75LVDS83DGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN75LVDS83DGGRG4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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**PACKAGE MATERIALS INFORMATION** 

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## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	_	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN75LVDS83DGGR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1

## **PACKAGE MATERIALS INFORMATION**

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN75LVDS83DGGR	TSSOP	DGG	56	2000	346.0	346.0	41.0

## DGG (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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